

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/743,803	LEE, YOUNG SIN	
		Examiner	Art Unit	Page 1 of 1
		BEN H. LIU	2616	

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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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